

Notice of References Cited	Application/Control No. 10/579,483	Applicant(s)/Patent Under Reexamination EICH ET AL.	
	Examiner BENYAM KETEMA	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0128191	07-2003	Strasser et al.	345/173
*	B	US-6,282,464	08-2001	Obradovich, Michael L.	701/1
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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